## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10673631	HWANG, YONG SUK
Examiner	Art Unit
Lee, Siu M	2611

SEARCHED						
Class	Subclass	Date	Examiner			
375	326, 150, 316, 371, 354, 373, 375, 376	12/07/2006	Siu M. Lee			

SEARCH NOTES				
Search Notes	Date	Examiner		
US-PGPUB	12/07/2006	Siu M. Lee		
USPAT	12/07/2006	Siu M. Lee		
USOCR	12/07/2006	Siu M. Lee		
EPO	12/07/2006	Siu M. Lee		
JPO .	12/07/2006	Siu M. Lee		
Derwent	12/07/2006	Siu M. Lee		
IBM_TDB	12/07/2006	Siu M. Lee		
Discussed the application with Chieh Fan	12/07/2006	Siu M. Lee		
Discuss the application with Chieh Fan	4/18/2007	Siu M. Lee		
EAST	4/18/2007	Siu M. Lee		

	INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner		
375	316, 326, 327, 373, 322	4/18/2007	Siu M. Lee		
455	204	4/18/2007	Siu M. Lee		